

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10596456	REDERT ET AL.
<b>Examiner</b>	<b>Art Unit</b>	
Phu K Nguyen	2628	

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
345	419, 424, 427	6/18/09	pn
382	292, 293	6/18/09	pn
701	3	6/18/09	pn

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
WEST search: perspective projection, scale, viewpoint	6/18/09	pn
INonPatent Literature: IEEE, ACM, Google	6/18/09	pn
Inventor Name search	6/18/09	pn

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>